

Search Notes

Application/Control No.

10/542,394

Examiner

Tran N. Nguyen

**Applicant(s)/Patent under
Reexamination**

FUJITA, KATSUFUSA

Art Unit

2834

SEARCHED

Class	Subclass	Date	Examiner
310	216 217 254 261	7/1/06	<i>[Signature]</i>
		↓	↓
336	210	7/4/06	<i>[Signature]</i>
	212	↓	↓
	219	↓	↓
	234	↓	↓
update	all above	12/12/06	<i>[Signature]</i>
update	all above	6/19/07	<i>[Signature]</i>
update	all above	10/23/07	<i>[Signature]</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
310	all	10/23/07	<i>[Signature]</i>
336	above	10/23/07	<i>[Signature]</i>

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference Search	10/23/07	<i>[Signature]</i>